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Active Millimeter-Wave Radiometry for Non-Destructive Testing/Evaluation of Composites - Glass Fiber Reinforced Polymer

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Abstract—Manufacture and in-service assessment of composite materials can be challenging since there is, yet, no standard method for testing them. Nevertheless, regular inspection is necessary to maintain structural integrity. This paper describes a non-destructive, broadband noise mapping method that uses a millimeter-wave radiometer to detect defects in composite materials. The W-band system is configured for transmission mode measurement in which an amplified photonic source illuminates a glass fiber reinforced polymer (GFRP) containing machined defects. A high sensitivity radiometer is used for imaging the sample. The radiometer consists of a Schottky diode-based frequency tripler and fundamental mixer.

Index Terms—Composite material, fiber reinforced polymer, millimeter wave, mixer, non-destructive, photonic, radiometer, Schottky diode, sensitivity.

I. INTRODUCTION

GLASS fiber is one of the most commonly used materials for reinforcing polymers. Other materials include carbon fiber and kevlar which regularly find wide applications in the automotive, aerospace and construction sectors. Glass fiber reinforced polymers (GFRP) are known to be strong, lightweight, and ductile and hence are successfully used for reinforcements [1]. Composite materials can develop cracks, delaminations, and voids and demand maintenance determined by imaging techniques to avoid structural deterioration and possible failure.

Non-destructive testing/evaluation (NDT/E) is routinely used for the inspection of flaws in composite materials. Several established methods have been used with varying success [2]. Methods such as radiography, ultrasonic, acoustic, X-ray, vibration, eddy current, etc., are commonly used in industrial NDT/E. Ultrasonic methods can suffer from a poor

signal-to-noise ratio due to high attenuation, while X-rays do not always provide a good contrast between defect and non-defect areas [3]. The use of electromagnetic (EM) radiation for investigation offers considerable benefits when evaluating a structure for deformities. This method does not require probe contact with the surface or couplant and can yield a depth of penetration dependent on the material loss tangent and operating frequency. The measurement resolution improves with increasing frequency enabling the inspection of defects in the sub-mm range at THz.

Within the millimeter-wave (mm-wave) band of inspection, the use of a waveguide probes is quite popular [4]-[6]. In this method, the near field sample interaction is measured with a waveguide and a network analyzer as the wave propagating in the material is reflected and scattered by discontinuities in the dielectric characteristics. Techniques such as dielectrically loading an open-ended waveguide can be used to reduce the waveguide size while maintaining resolution [3]. Active thermographic NDT reported in [5], [7], illuminates the sample and detects the differential temperature change using a thermal camera. Other EM methods include free space microwave NDT using horn lens antennas with a network analyzer [8] and the use of inter-digit sensor to measure the S-parameters along a defected surface [9]. Polarization studies on a GFRP sample using a synthetic aperture radar technique is reported in [10].

Table I and II presents an overview of some specific research published in the field of NDT/E. Table I compares research based on the technique used for non-destructive testing of a composite sample. For simplicity, only techniques used to image GFRP samples have been included. Also, methods like the ones included in the table have been omitted. Table II compares research based on applications where a W-band system has been used for inspection. The active mm-wave inspection method presented in this paper represents a new approach for inspection of composite materials in comparison to the existing research. This technique for inspection combines two different research fields which presents a potentially new and interesting area for study.

In this method, a broadband photonic source generating random mm-wave noise is quasi-optically projected onto the sample. Transmitted signal variations due to sample inhomogeneity are detected by the W-band radiometer as it is

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TABLE I
OVERVIEW OF EM IMAGING TECHNIQUES USED FOR NDT/E OF GFRP

NDT/E technique	Frequency (GHz)	TX/RX Scheme	Field Analysis	Reference
Inverse synthetic aperture radar (ISAR)	8-18	Radar feed-horn	Far field	Buyukozturk et al. [11]
Frequency Modulated Continuous Wave (FMCW) radar	75-110	Radar feed-horn	Near field	Dobmann et al. [12]
Active microwave thermography	2.4	Horn/thermal camera	Near field	Foudazi et al. [7]
Terahertz time-domain spectroscopy	0-3000	Femtosecond laser/photoconductive dipole antennas	-	Richter et al. [13]
Infrared thermography	-	Photographic flashes/IR camera	-	Ibarra-Castaneda et al. [14]
Synthetic aperture radar (SAR)	75-110	Radar feed-horn	-	Nezadal et al. [10]
Microwave heating	Low power-18, High power-2.54	Waveguide/thermal camera	Far field	Cheng et al. [5]
Active millimeter-wave radiometry	75-110	Noise source/radiometer	Far field	Present system

Only techniques used for imaging GFRP samples are included in the table.

TABLE II
OVERVIEW OF mm-WAVE SYSTEMS USED FOR VARIOUS NDT/E APPLICATIONS

NDT/E Application	System	Sensitivity (K) @ integration time	Reference
Detection of space shuttle tile defects	Passive	0.3 @ 1 s	Clancy et al. [15]
Inspection of bonding quality in polymers	Active	-	Bakhtiari et al. [16]
Detection of carbon in soot collection filters	Active	-	Shibuya et al. [17]
Corrosion detection in aircraft structures	Active	-	Seah et al. [18]
Monitor healing of burn wounds ¹	Passive	0.2 @ 1 s	Harmer et al. [19]
Monitoring of vital signs ¹	Active	-	Bakhtiari et al. [20]
Inspection of defects in materials	Active	0.53 @ 3.3 ms	Present system

All systems included in the table are centered at 94 GHz.

¹ Medical monitoring is usually not categorized under NDT/E but it has been included to show the use of W-band systems for non-intrusive inspection.

raster scanned along the focal plane. Signals passing through the GFRP sample undergo scattering from edges, as well as constructive and destructive interference from material weavings or multiple layers. An important advantage of using a broadband imaging system is the inherent averaging of standing waves across the operational bandwidth which results for interfaces [21].

II. ELECTROMAGNETIC WAVE INTERACTION AT BOUNDARIES OF DIFFERENT MEDIUMS

A general representation of a plane wave normally incident at an interface is shown in Fig. 1. We assume the wave is propagating in the $+z$ direction. The medium is considered lossless ($\alpha = 0, \beta = k$). If the medium was lossy, the propagation constant would be $\gamma = \alpha + j\beta$. The permittivity of medium 1 and medium 2 are ϵ_1 and ϵ_2 , respectively, while the permeability, μ_0 of both the mediums is 1. When a wave travelling through medium 1 is incident at the boundary of the

medium 2, part of the wave is transmitted while some part is reflected. The electric fields for the incident, reflected, and transmitted, respectively are given below

$$E_{y,i}(z,t) = A_i e^{j(\omega t - k_1 z)} \quad (1)$$

$$E_{y,r}(z,t) = B_r e^{j(\omega t + k_1 z)} \quad (2)$$

$$E_{y,t}(z,t) = A_t e^{j(\omega t - k_2 z)} \quad (3)$$

where k_1 and k_2 are the wave numbers for medium 1 and medium 2, respectively. The wave number can be calculated as $k = \omega \sqrt{\epsilon_r}$ where ϵ_r is the complex relative permittivity. The constant terms A and B represent wave propagation in the $+z$ and $-z$ -directions, respectively. The wave impedance of the propagating wave is $Z = \sqrt{\mu/\epsilon}$. The electric and magnetic fields are related through the wave impedance as $Z = E/H$. Since the tangential component of the electric field

and magnetic fields remains continuous at the boundary ($z = 0$), we can write

$$E_{y,i}(z = 0, t) + E_{y,r}(z = 0, t) = E_{y,t}(z = 0, t) \quad (4)$$

$$H_{x,i}(z = 0, t) + H_{x,r}(z = 0, t) = H_{x,t}(z = 0, t) \quad (5)$$

From the boundary conditions shown above, we obtain

$$A_i + B_r = A_t \quad (6)$$

$$\frac{A_i}{Z_1} - \frac{B_r}{Z_1} = \frac{A_t}{Z_2} \quad (7)$$

The reflection coefficient, Γ and transmission coefficient, T can be obtained from [22], as shown below

$$\Gamma = \frac{B_r}{A_i} = \frac{Z_2 - Z_1}{Z_1 + Z_2} \quad (8)$$

$$T = \frac{A_t}{A_i} = 1 + \Gamma = \frac{2Z_2}{Z_1 + Z_2} \quad (9)$$

Fig. 1. Transmission and reflection from a general interface at normal incidence.

A normally incident EM wave at an air-dielectric-air interface is illustrated in Fig. 2. The permittivity of air and dielectric mediums are ϵ_0 and ϵ_r , respectively. The permeability, μ_0 of both mediums is 1. At the first interface, the wave is partially transmitted into the next medium and partially reflected. The phase of individual terms when summed will be different due to the phase difference between the dielectric-air boundary. This additional phase difference can be represented as $k_2 d$ after crossing the interface. We assume the reflection coefficient from the air-dielectric interface is Γ_1 in the $+z$ direction and $-\Gamma_1$ in the $-z$ direction. Since medium 3 is identical to medium 1, $\Gamma_2 = -\Gamma_1$ and $-\Gamma_2 = \Gamma_1$. Similarly, the transmission coefficient through the air-dielectric interface is assumed as $T_1^+ = 1 + \Gamma_1$ in the $+z$ direction and $T_1^- = 1 - \Gamma_1$ in the $-z$ direction. The total reflected electric field is obtained as shown

$$E_r(z) = E_i \left[\Gamma_1 + T_1^+ T_1^- \Gamma_2 e^{-j2k_2 d} + T_1^+ (-\Gamma_2 \Gamma_1) \Gamma_1^- \Gamma_2 e^{-j4k_2 d} + \dots \right] \quad (10)$$

Fig. 2. Transmission and reflection from an air-dielectric-air interface.

$$E_r(z) = E_i \left[\Gamma_1 - \Gamma_1 (1 - \Gamma_1^2) e^{-j2k_2 d} \left\{ 1 + \Gamma_1^2 e^{-j2k_2 d} + \dots \right\} \right] \quad (11)$$

The total reflection coefficient is

$$\Gamma = \frac{E_r(z)}{E_i} = \Gamma_1 \left[1 - \frac{(1 - \Gamma_1^2) e^{-j2k_2 d}}{1 - \Gamma_1^2 e^{-j2k_2 d}} \right] \quad (12)$$

$$\Gamma = \frac{E_r(z)}{E_i} = \frac{\Gamma_1 (1 - e^{-j2k_2 d})}{1 - \Gamma_1^2 e^{-j2k_2 d}} \quad (13)$$

In a similar way, the total transmitted electric field can be obtained from Fig. 2 as follows

$$E_t(z) = E_i \left[T_1^+ T_1^- e^{-jk_2 d} + T_1^+ (-\Gamma_2 \Gamma_1) \Gamma_2^- e^{-j3k_2 d} + \dots \right] \quad (14)$$

$$E_t(z) = E_i \left[(1 - \Gamma_1^2) e^{-jk_2 d} \left\{ 1 + \left(\Gamma_1^2 e^{-j2k_2 d} \right) + \left(\Gamma_1^2 e^{-j2k_2 d} \right)^2 + \dots \right\} \right] \quad (15)$$

The total transmission coefficient is

$$T = \frac{E_t(z)}{E_i} = \frac{(1 - \Gamma_1^2) e^{-jk_2 d}}{1 - \Gamma_1^2 e^{-j2k_2 d}} \quad (16)$$

Fiber reinforced composites usually exhibit anisotropy and hence the characterization of its material properties depend on the orientation of the measurement plane [22]. For an incoming wave that is obliquely incident, reflections from an anisotropic and heterogeneous material surface are not specular. Scattering of the incident wave from these surfaces depend on properties such as surface roughness, angle of incidence, and material loss [23]. Diffuse reflection from rough surfaces cause the field to scatter in different directions and are rather difficult to calculate. If we consider scattering based on the object dimension they can be classified into two commonly used scattering mechanisms, namely Rayleigh scattering, where the object dimension is small compared to wavelength ($\sim d \leq 0.1\lambda$), and Mie scattering, where the object dimension is large compared to wavelength ($\sim d > 10\lambda$). Since the system is configured for normal incidence with the sample, the general analysis for oblique incidence is not covered here but is explained in [24].

III. SCHOTTKY DIODE-BASED DEVICE MEASUREMENTS AND ANALYSIS

The general design methodology for the six-anode Schottky balanced frequency tripler was based on the topology presented in [25]. The fundamental mixer design consisted of a two-anode balanced structure based on the work in [26]. The discrete Schottky diodes used in these designs are fabrication technology developed by Teratech Components Ltd. EM simulations were conducted in Ansoft's HFSS (High Frequency Structure Simulator), while the non-linear circuit simulation was implemented in Keysight's ADS (Advanced Design System). The test benches for measuring the W-band frequency tripler and W-band fundamental mixer are presented in Figs. 3 and 4, respectively.

Fig. 3. Block diagram for W-band frequency tripler measurement.

Fig. 4. Block diagram for W-band fundamental mixer measurement.

A. W-band Frequency Tripler

To calibrate the input power to the W-band frequency tripler, an 18-40 GHz power amplifier and an Agilent power meter were used. An isolator was placed after the amplifier to prevent standing waves from affecting the measurement. The tripler bias was tuned using an external supply. The output was measured using an Erickson PM4 power meter. Fig. 5 shows the uncorrected room temperature performance of the tripler at optimum bias. A measured conversion efficiency of 8% was obtained in the 78-102 GHz frequency band for 100 mW input. The decrease in power at the edges is likely due to impedance matching issues or alignment problems during assembly. Nevertheless, the performance was enough to supply local oscillator (LO) power to the fundamental mixer.

Fig. 5. Measured output power across complete W-band for 100 mW input.

B. W-band Fundamental Mixer

Standard Y-factor analysis was implemented to measure the W-band fundamental mixer performance. An absorber at room temperature, P_{hot} and another immersed in liquid nitrogen, P_{cold} were the two targets for finding the Y-factor ratio. An Agilent 346C noise source was used to calibrate the IF chain. The mixer IF performance was measured using a Rohde & Schwarz, FSQ26 spectrum analyzer. A Matlab code was implemented for generating the mixer noise temperature, T_{mix} and conversion gain, G_{mix} based on the following expression

$$T_{rec} = T_{mix} + \frac{T_{IF}}{G_{mix}} \quad (17)$$

where T_{rec} is the receiver noise temperature and T_{IF} is the IF noise temperature. The measured mixer noise temperature and conversion loss are shown in Fig. 6. The room temperature, double sideband (DSB) noise temperature was generally between 400 and 600 K with a conversion loss of up to 5 dB. In order to reduce ripples in the measurement, the first LNA at the IF had a low VSWR. The detailed measurement results for the W-band fundamental mixer are presented in [27].

Fig. 6. Ambient noise temperature and conversion loss of W-band fundamental mixer centered at 94 GHz.

C. Radiometer Sensitivity

The radiometer sensitivity was characterized by measuring the noise equivalent temperature difference (NETD) of the system. This value provided an estimate of the minimum signal that could be measured in the presence of noise fluctuations. The sensitivity of a radiometer is defined as the ratio of its RMS noise voltage, V_{rms} to the temperature sensitivity of the system, dV/dT , where dV and dT are the changes in measured voltage and temperature, respectively.

$$NETD = \frac{V_{rms}}{dV/dT} \quad (18)$$

The radiometer set-up for NETD measurement is shown in Fig. 7. A SR560 low noise preamplifier from Stanford Research Systems and an Agilent DSOX 2024A digital storage oscilloscope (DSO) were also required for the measurement. The zero bias Schottky detector used for signal rectification had a low-level sensitivity of 500 V/W.

Fig. 7. Set-up for radiometer characterization includes a Gunn source, self-biased W-band frequency tripler, W-band fundamental mixer, and LNAs.

The complete NETD set-up and measurement procedure is given in [28]. The relation between NETD and integration time varies as the inverse square root when the gain variation is small. This can be seen from

$$NETD = (T_S + T_R) \left[\frac{1}{B\tau} + \left(\frac{\Delta G}{G} \right)^2 \right]^{1/2} \quad (19)$$

where τ is the integration time (related to filter bandwidth), B is the RF bandwidth, T_R is the receiver noise temperature, T_S is the scene temperature and G is the IF amplifier gain. If the gain varies by ΔG , then the sensitivity of the radiometer system can be improved by increasing B and/or decreasing T_R . Fig. 8 shows the plot for the measured and calculated NETD for the radiometer. The calculated NETD curve was generated from (19) using $T_S = 300$ K, $T_R = 2000$ K and $B = 10$ GHz. By fitting the calculated with the measured results, gain instability of 0.025% was obtained. Gain fluctuation is usually higher for longer integration time as they have a $1/f$ power spectrum [29].

Fig. 8. Measured (round marker) and calculated (square marker) NETD results after accounting for gain instabilities in the measurement.

IV. ACTIVE RADIOMETER SYSTEM ARCHITECTURE

The active radiometer system developed for NDT of GFRP can be divided into three main parts; the photomixer-based transmitter for illuminating the sample, a quasi-optical test bench that comprised of polytetrafluoroethylene (PTFE) lenses for focusing the free space signal and the receiver which was a high sensitivity W-band Schottky diode-based radiometer.

A. Photomixer

Broadband mm-wave power was generated by a photomixer driven by optical noise centered around a wavelength of $1.5 \mu\text{m}$ [30]. The near-infrared power was provided by amplified spontaneous emission (ASE) from an erbium-doped optical fiber amplifier (EDFA). The photomixer consisted of a high speed InGaAs photodiode coupled to a standard rectangular WR10 waveguide. Although the photomixer is normally used to produce a single W-Band frequency when driven by two lasers [31], in this case the frequency components within the incoherent light from the EDFA beat with each other to generate a wide mm-wave spectrum. This spectrum was characterized as shown in Fig. 9 using a Fourier transform spectrometer. The sharp spectral features appeared due to variations in impedance match with frequency between the photodiode and waveguide sections. Output power indicated at frequencies below the 59 GHz waveguide cut-off is an artefact arising from the Fourier transformation process.

Fig. 9. Output power spectrum from a photomixer driven by optical noise.

The photomixer's output was amplified and passed through a calibrated rotary vane attenuator before being coupled into free space by a pyramidal feedhorn. The illumination system settings were such that a maximum, frequency integrated, illumination power of 1 mW was available from the measurements described below. The photomixer's broadband output was amplified by a narrow-band power amplifier which had 20 dB linear gain from 80 to 100 GHz. Therefore the 3 dB bandwidth of the power amplifier was considered as the operational bandwidth of the system.

B. Quasi-Optical Test Bench

The quasi-optical test bench employed two equal sets of plano-convex PTFE lenses on either side of the sample under test. The two lenses were mounted back-to-back, one for obtaining an electromagnetic plane wave and the other for focusing this plane wave. One set of lenses was used between the transmitter and sample and other between the sample and

radiometer. The complete test bench is shown in Fig. 10. The plano-convex lenses, separated by the sum of their focal lengths, were arranged to obtain a narrow Gaussian beam waist at the sample. The position of the lenses was verified by a Gaussian beam software, GRASP (Generalized Reflector Antenna Analysis Software Package) developed by TICRA.

Fig. 10. Measurement test bench includes photomixer noise source (inset), plano-convex lenses, composite sample, polarizer, and W-band radiometer (inset).

C. Radiometer

The W-band radiometer was driven with a fixed tuned Gunn oscillator at 31.5 GHz. A Gunn source was chosen for its stability and low noise compared to other sources, such as backward wave oscillators (BWO) [32]. The signal from the oscillator was frequency tripled and supplied as an LO source power of approximately 7 mW at 94 GHz to the W-band fundamental mixer. The IF signal bandwidth was 1-18 GHz, but was measured upto 10 GHz due to the unavailability of LNAs with low noise figure (NF) and VSWR to cover the entire frequency band. Fig. 11 shows the LO generation scheme for the radiometer. Signal amplification of the mixer IF was performed using two cascaded 1-10 GHz LNAs. The P1 dB compression points for the LNAs were 12 dBm and 13 dBm, respectively. As per the expression in (17), the receiver noise temperature is heavily dependent on the noise performance of the first LNA at the IF. Hence a LNA with 30 dB gain, 1.4 dB NF, and 1.2 VSWR was placed first in the IF chain. The second LNA had a 32 dB gain, 1.55 dB NF, and 1.3 VSWR. A digital voltmeter was used to record the varying output voltage due to sample inhomogeneities.

Fig. 11. LO generation scheme for the radiometer centered at 94 GHz.

V. SYSTEM CALIBRATION

The system calibration involved placement of the plano-convex PTFE lenses on the quasi-optical test bench. The lens immediately after the noise source converted the diverging Gaussian beam into a collimated beam between the two lenses, which was then focused onto the sample. The lenses on the receiver side focused the transmitted diverging signal on the radiometer. To ensure the required focusing was available, 60-mm focal length lenses were selected closer to the sample. The outer lenses had a focal length of 150 mm. A chopper and lock-in amplifier were employed to account for instabilities in the radiometer, however, it was seen that this was not necessary due to high signal to noise and good system stability. This may however prove advantageous for samples with lower transparency or increased signal scattering.

Fig. 12. Quasi-optical Gaussian beam model from GRASP. Tx is the noise source, Rx is the radiometer and L_1 , L_2 , L_3 , and L_4 are the plano-convex lenses.

Fig. 13. The 3 dB Gaussian beam intensity graphs showing (a) converged beam at Rx (b) parallel beam waist between L_3 - L_4 .

The lens positions were aligned to maximize the received signal. Fig. 12 illustrates the optics arrangement in GRASP. Beam intensity plots obtained from the simulator are shown in Fig. 13(a), which indicates the beam at the radiometer, while

Fig. 13(b) shows the parallel beam between the two lenses on the radiometer side, i.e., $L_3 - L_4$. The results show a shift in the beam waist along the direction of propagation of the signal. This shift was due to approximation of the feedhorn and lens parameters which were needed for simulating the optics in GRASP. The spot size determined as describe above was approximately 2.5 mm in diameter.

VI. ACTIVE RADIOMETER IMAGING RESULTS

To demonstrate the imaging capability of the system, defects in the form of steps and a wedge with gradually varying depth were machined on a MDF (medium density fiber) sample. Fig. 14 shows the MDF sample used for inspection. The sample had an overall dimension of $70 \times 85 \times 25 \text{ mm}^3$. Each step was $20 \times 15 \times 5 \text{ mm}^3$. The wedge-shaped defect had a dimension of $20 \times 60 \text{ mm}^2$ with a maximum depth of 20 mm.

Fig. 14. Photograph of the machined MDF sample showing step and wedge defects.

Fig. 15 shows the transmission and scattering characteristics from the MDF sample as it was linearly scanned across the center of the step and wedge defects. For this imaging experiment, both the transmitter and receiver were co-polarized. The transmission power through the sample was characterized as a voltage signal from the radiometer. The linear scan in Fig. 15(a) clearly shows the transmission signal changing due to varying depths in the step defect. While moving from left to right on the sample, each step increased in height by 5 mm. This corresponds to a decrease in voltage measured at the radiometer for each step. Since there was no change in polarization at the radiometer, signal transmission along non-defected area shows a constant voltage.

A sharp decrease in voltage was seen at the edges of the sample which indicates attenuation of the scattered fields due to change in polarization. The plot in Fig. 15(b) shows a gradual decrease in signal transmission as the sample is scanned from a larger depth (less signal attenuation) to a smaller depth (more signal attenuation). As with the step defects, the two edges on either ends of the wedge showed a decrease in voltage due to scattering of the signal. The difference in voltage levels at these edges is due to the randomness of the source transmission as these levels changed at every scan. From the transmission data obtained in Fig. 15, if a linear map of the output voltage and the sample length is generated it would be possible to estimate depth information of the defects.

Fig. 15. Linear scans for MDF sample with defects of varying depths. (a) Step defect. (b) Wedge-shaped defect.

The intensity plots for the MDF test sample are shown in Fig. 16. Each step defect illustrated a maximum in transmitted signal along the surface with varying depths, whereas the edges showed a minimum due to scattering. The signal transmission along the non-defected areas was constant throughout the sample. For the wedge-shaped defect, the signal transmission showed a gradual decrease in intensity as it moved towards a smaller depth in the wedge. The transmission characteristics obtained from the sample indicates that it would be possible to estimate the defect density with reasonable accuracy, while the signal scattering would help in identifying cracks and edges in certain samples.

In the interest of correlating the transmission characteristics illustrated in Fig. 16 with theoretical expression, material properties for MDF were substituted in (16). An approximate value of $2.5 + j 0.02$ was selected for the relative permittivity. On solving the equation and taking the integral average across the bandwidth, a decrease of approximately 1.5 dB in received power was obtained while moving from the 10 mm thick part to the 20 mm thick part of the sample. This translated to 1.95 mV difference in voltage at the detector. To validate imaging results from the MDF sample, signal transmission between the step defects with 10 mm thickness difference should show a value similar to the detected voltage. On examining the linear scan in Fig. 15(a), the difference between voltage levels for two step defects with 10 mm thickness difference was approximately 2.2 mV. This shows that the imaging results reasonably agree with the transmission theory.

Fig. 16. Intensity profile for MDF sample showing maximum signal transmission along the defect surface and minimum transmission along the defect edges.

The GFRP sample shown in Fig. 17 was carefully machined to have dimensions of $40 \times 30 \times 5 \text{ mm}^3$. Two blind hole defects of 2 and 4 mm diameters were drilled into the sample, to 3 mm depth. As the defects on the sample moved into the incident beam of the radiometer a gradual change in output voltage was noted. Since the spontaneous thermal radiation of GFRP sample is low compared to the transmitted photonic noise, the radiometer only sees changes in transmission noise due to the air-dielectric interface. The change in transmission signal intensity across the sample is illustrated in Fig. 18. It is clear from this figure that the right-hand feature is associated with the 4-mm diameter defect. As mentioned earlier, the decrease in signal voltage on approaching a defect was associated with signal scattering from its edges. This conclusion assumes that the large bandwidth of the noise source would overall average out the effects of destructive and constructive interference of the incident and reflected waves from the defect area, leaving the drop in measured transmitted intensity to be due to scattering. However, it is not unlikely that an internal standing wave is present at certain frequencies, which reduces or increases the return loss due to reflections.

Fig. 17. Photograph of the GFRP sample showing two machined circular defects of 2 mm and 4 mm diameters.

Fig. 18. Intensity profile for the GFRP sample showing maximum and minimum signal transmission.

VII. CONCLUSION

This work demonstrates the successful application of an active W-band radiometer system for imaging composites, particularly a GFRP sample with machined defects as small as a few mm in diameter. The system described here consisted of a photonic noise source and a high sensitivity Schottky-based radiometer for detecting defects as a change in measured output voltage. The radiometer had a noise equivalent temperature difference of 0.53 K at 3.33 ms integration time. A spot size of approximately 2.5 mm in diameter was obtained using Gaussian beam modelling in GRASP. The linear scans along with the intensity plots for MDF sample demonstrated the imaging capability of the system. The results obtained

from imaging of the GFRP sample confirmed that active imaging with a radiometer is a viable option for NDT/E. In principle, the active radiometer-based NDT/E system can be compact and fast scanning times achieved due to its simple voltage output for image generation. The attraction of such a system is that it is easy to implement and that it has a small form factor, as demanded by NDT/E inspections in the field. With future integration bringing down manufacturing costs, this makes for a clear path to implementation where other systems do not progress from the laboratory. In practice, a robotic *in situ* alignment can be envisaged with existing precision robotic positioners.

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